PCN Number: 2022		21215004.0		PCN Date:		Date:	December 16, 2022		
Title: DP83869H Firmware			and	Datasheet Updates					
<b>Customer Contact:</b>		PCN Manager		Dept:			Quality Services		
Cha	nge Ty	pe:							
Assembly Site				Assembly Process			Assembly Materials		
☑ Design			X	Electrical Specification			Mechanical Specification		
☐ Test Site			Packing/Shipping/Labeling			Test Process			
☐ Wafer Bump Site			Wafer Bump Material			Wafer Bump Process			
☐ Wafer Fab Site			Wafer Fab Materials			Wafer Fab Process			
				Part number change					
PCN Details									
Des	criptio	n of Change:							
This notification is to communicate an update for the DP83869H devices to correct an occasional anomaly in fiber auto-negotiation. As a result, the PHYIDR2 Register (address = $0x3$ ) value is changing from $0xA0F1$ to $0xA0F3$ .									
	Customers may need to update their application firmware as the PHY driver may be checking for PHYIDR2 register 0x3 content.								

It is recommended to use an OR function for PHYIDR2 register contact check in the firmware so it can be used seamlessly.

The product datasheet(s) is being updated as summarized below.



DP83869HM

SNLS614B - SEPTEMBER 2018 - REVISED DECEMBER 2022

С	hanges from Revision A (September 2018) to Revision B (December 2022)	Page
•	Changed fiber compliance to current Specification	1
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
•	Deleted leading 0 from all register, read, and write statements	25
•	Deleted 1000Base-X fiber application clarification, bug has been fixed	33
•	Changed bridge mode image and description to clarify TX and RX pin behavior	38
•	Changed description of Media Converter mode to support Unmanaged Media Converter mode in resbug fix	
•	Changed register read and writes to correct values with comments	39
•	Changed number of PHYs and size of PHY address to correct values	
•	Added clarification for Auto-Negotiation setting	48
•	Changed strapping modes in the figure and description to correct values	48
•	Changed Table 10-1 to clarify Frequency Tolerance	
•	Changed Table 10-2 to clarify Frequency Tolerance	92
•	Changed the two-supply config figure to the correct number of pins for VDDIO and VDD1P1, also ch	nanged
	the pin name from VDDA1P1 to VDD1P1	95
•	Changed the three-supply config figure to the correct number of pins for VDDIO and VDD1P1, also the pin name from VDDA1P1 to VDD1P1	changed

The datasheet number will be changing.

CurrentNewProduct FamilyDatasheet NumberDatasheet NumberDP83869HMSNLS614ASNLS614B

These changes may be reviewed at the datasheet links provided:

http://www.ti.com/product/DP83869HM

Affected devices are listed in the Product Affected section of this document.

## **Reason for Change:**

Improved device functionality

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

None.

**Product Affected:** 

DP83869HMRGZT DP83869HMRGZT

## **Qualification Report**

## **Approve Date 07-Nov-2019**

**Qualification Results** 

Data Displayed as: Number of lots / Total sample size / Total failed

Type	Test Name / Condition	Duration	Qual Device: DP83869-A2	Qual Device: DP83869A0	Qual Device: PDP83869A1	QBS: Process References DS90UH947TRGCR Q1
HTOL	High Temp Operating Life, 125C	1000 Hours	-	1/77/0	1/77/0	3/231/0
ELFR	Early Life Failure Rate, 125C	48 Hours	-			3/2400/0
TC	**T/C -65C/150C	500 Cycles	-	3/231/0	-	3/231/0
AC	**Autoclave 121C	96 Hours	-	3/231/0	-	3/231/0
HAST	**Biased HAST, 110C/85% RH	264 Hours	-	3/231/0	1	3/231/0
HTSL	**High Temp. Storage Bake	170C (168, 420 Hours)	-	3/231/0	-	
ED	Electrical Characterization	Limit Verification	Pass	-	Pass	Pass
CDM	ESD CDM	1500V	1/3/0	1/3/0	1/3/0	1/3/0
HBM	ESD HBM	4000V	1/3/0	1/3/0	1/3/0	1/3/0
LU	Latch-up, 25C	(per JESD78)	1/6/0	1/6/0	1/6/0	1/6/0
LU	Latch-up, 125C	(per JESD78)	1/6/0	1/6/0	1/6/0	1/6/0
BPC	Bond Pad Cratering Check	Post 500 Temp Cycle	-	3/5/0	-	
BPC	Bond Pad Cratering Check	Post assembly	-	3/6/0	-	
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	-	Pass	ı	
TC-BP	Post T/C bond-pull strength	Wires	-	3/30/0	-	
TC- SAM	Post Temp Cycle SAM	Pre and Post MSL	-	3/30/0	-	
VM	Visual Quality Reliability Inspection	Post 500 Cycle Temp Cycle	-	3/2/0	ı	
VM	Visual Quality Reliability Inspection	Post HTSL	-	3/2/0	-	
WBP	Bond Pull	Wires	-	3/228/0	=	
BLR	BLR - Temp Cycle (QFN), -40/125C	1000 Cycles	-	1/32/0	-	

Type	Test Name / Condition	Duration	Qual Device: DP83869-A2	Qual Device: DP83869A0	Qual Device: PDP83869A1	QBS: Process References DS90UH947TRGCR Q1
SD	Solderability w. Bake precon	4 Hours/@155C, Pb Free	-	3/66/0	-	
SD	Solderability w. Bake precon	4 Hours/@155C, Pb	-	3/66/0	-	

QBS: Qual By Similarity

- Qual Device DP83869 is qualified at LEVEL2-260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
- The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Ho urs, and 155C/240 Hours
- The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/ Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contact shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com

## **IMPORTANT NOTICE AND DISCLAIMER**

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (<a href="www.ti.com/legal/termsofsale.html">www.ti.com/legal/termsofsale.html</a>) or other applicable terms available either on ti.com or provided in conjunction with such TI

products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.